## 1GHz INPUT DIVIDE BY 2, 4, 8 PRESCALER IC FOR PORTABLE SYSTEMS

$\mu$ PB1509GV is a divide by $2,4,8$ prescaler IC for portable radio or cellular telephone applications. $\mu$ PB1509GV is a shrink package version of $\mu$ PB587G so that this small package contributes to reduce the mounting space.
$\mu$ PB1509GV is manufactured using NEC's high fT NESAT ${ }^{\text {TM }}$ IV silicon bipolar process. This process uses silicon nitride passivation film and gold electrodes. These materials can protect chip surface from external pollution and prevent corrosion/migration. Thus, this IC has excellent performance, uniformity and reliability.

## FEATURES

- High toggle frequency : fin $=50 \mathrm{MHz}$ to $700 \mathrm{MHz} @ \div 2$, 50 MHz to $800 \mathrm{MHz} @ \div 4$, 50 MHz to $1000 \mathrm{MHz} @ \div 8$
- Low current consumption
: $5.0 \mathrm{~mA} @ \mathrm{Vcc}=3.0 \mathrm{~V}$
- High-density surface mounting
: 8 pin plastic SSOP (175mil)
- Supply voltage
: $\mathrm{Vcc}=2.2$ to 5.5 V
- Selectable division
$: \div 2, \div 4, \div 8$


## APPLICATION

- Portable radio systems
- Cellular/cordless telephone 2nd Local prescaler and so on.

ORDERING INFORMATION

| PART NUMBER | PACKAGE | MARKING | SUPPLYING FORM |
| :---: | :--- | :---: | :--- |
| $\mu$ PB1509GV-E1 | 8 pin plastic SSOP <br> $(175$ mil) | 1509 | Embossed tape 8 mm wide. Pin 1 is in tape pull-out <br> direction. 1000p/reel. |

Remarks : To order evaluation samples, please contact your local NEC sales office. (Part number for sample order: $\mu$ PB1509GV)

## PIN CONNECTION (Top View)



| Pin NO. | Pin Name |
| :---: | :---: |
| 1 | VCc1 |
| 2 | IN |
| 3 | $\overline{\mathrm{NN}}$ |
| 4 | GND |
| 5 | SW1 |
| 6 | SW2 |
| 7 | OUT |
| 8 | VCc2 |

PRODUCT LINE-UP

| Product No. | $\begin{gathered} \mathrm{Icc} \\ (\mathrm{~mA}) \end{gathered}$ | Vcc <br> (V) | $\begin{gathered} \div 2 \\ \mathrm{fin}^{2} \\ (\mathrm{MHz}) \\ \hline \end{gathered}$ | $\begin{gathered} \div 4 \\ \mathrm{fin}^{2} \\ (\mathrm{MHz}) \\ \hline \end{gathered}$ | $\begin{gathered} \hline \div 8 \\ \mathrm{fin}^{2} \\ (\mathrm{MHz}) \\ \hline \end{gathered}$ | Package | Pin Connection |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mu \mathrm{PB} 587 \mathrm{G}$ | 5.5 | 2.2 to 3.5 | 50 to 300 | 50 to 600 | 50 to 1000 | 8 pin SOP (225 mil) | NEC Original |
| $\mu$ PB1509 GV | 5.0 | 2.2 to 5.5 | 50 to 700 | 50 to 800 | 50 to 1000 | 8 pin SSOP (175 mil) |  |

## Remarks

This table shows the TYP values of main parameters. Please refer to ELECTRICAL CHARACTERISTICS. $\mu$ PB587G is discontinued.

## INTERNAL BLOCK DIAGRAM



## SYSTEM APPLICATION EXAMPLE

One of the example for usage


This block diagram schematically shows the $\mu$ PB1509GV's location in one of the example application system. The other applications are also acceptable for divider use.

## Pin Explanations



## ABSOLUTE MAXIMUM RATINGS

| PARAMETER | SYMBOL | CONDITION | RATINGS | UNIT |
| :--- | :---: | :--- | :---: | :---: |
| Supply voltage | $\mathrm{V}_{\mathrm{cc}}$ | $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$ | 6.0 | V |
| Input voltage | $\mathrm{V}_{\mathrm{in}}$ | $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}, \mathrm{SW} 1, \mathrm{SW} 2$ pins | 6.0 | V |
| Total power dissipation | $\mathrm{PD}_{\mathrm{D}}$ | Mounted on double sided copper clad $50 \times 50 \times 1.6$ <br> mm epoxy glass PWB $\left(\mathrm{T}_{\mathrm{A}}=+85^{\circ} \mathrm{C}\right)$ | 250 | mW |
| Operating ambient <br> temperature | $\mathrm{T}_{\mathrm{A}}$ |  | -40 to +85 | ${ }^{\circ} \mathrm{C}$ |
| Storage temperature | $\mathrm{T}_{\text {stg }}$ |  | -55 to +150 | ${ }^{\circ} \mathrm{C}$ |

## RECOMMENDED OPERATING CONDITIONS

| PARAMETER | SYMBOL | MIN. | TYP. | MAX. | UNIT | NOTICE |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| Supply voltage | $\mathrm{V}_{\mathrm{Cc}}$ | 2.2 | 3.0 | 5.5 | V |  |
| Operating ambient temperature | $\mathrm{T}_{\mathrm{A}}$ | -40 | +25 | +85 | ${ }^{\circ} \mathrm{C}$ |  |

ELECTRICAL CHARACTERISTICS ( $\mathrm{T}_{\mathrm{A}}=\mathbf{- 4 0}$ to $+85^{\circ} \mathrm{C}, \mathrm{Vcc}=2.2$ to 5.5 V )

| PARAMETERS | SYMBOLS | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Circuit current | Icc | No signals, $\mathrm{V}_{\mathrm{cc}}=3.0 \mathrm{~V}$ | 3.5 | 5.0 | 5.9 | mA |
| Upper Limit Operating Frequency 1 | fin(U) 1 | $P_{\text {in }}=-20$ to 0 dBm | 500 | - | - | MHz |
| Upper Limit Operating Frequency 2 | fin(U) ${ }^{\text {a }}$ | $\begin{array}{r} \text { Pin }=-20 \text { to }-5 \mathrm{dBm} @ \div 2 \\ @ \div 4 \\ @ \div 8 \end{array}$ | $\begin{gathered} 700 \\ 800 \\ 1000 \end{gathered}$ | $\begin{aligned} & - \\ & - \end{aligned}$ | — | MHz |
| Lower Limit Operating Frequency 1 | $\mathrm{fin}_{\text {in }}(\mathrm{L})$ | $\mathrm{P}_{\text {in }}=-20$ to 0 dBm | - | - | 50 | MHz |
| Lower Limit Operating Frequency 2 | $\mathrm{fin}_{\text {in }}(\underline{2}$ | $\operatorname{Pin}=-20$ to -5 dBm | - | - | 500 | MHz |
| Input Power 1 | Pin1 | $\mathrm{fin}^{\text {}}$ 5 50 MHz to 1000 MHz | -20 | - | -5 | dBm |
| Input Power 2 | Pin2 | $\mathrm{fin}_{\text {i }}=50 \mathrm{MHz}$ to 500 MHz | -20 | - | 0 | dBm |
| Output Voltage | Vout | $R \mathrm{~L}=200 \Omega$ | 0.1 | 0.2 | - | Vp-p |
| Divide ratio control input high | $\mathrm{V}_{\mathbf{H} 1}$ | Connection in the test circuit | Vcc | Vcc | Vcc | - |
| Divide ratio control input low | VIL1 | Connection in the test circuit | $\begin{gathered} \text { OPEN } \\ \text { or } \\ \text { GND } \end{gathered}$ | $\begin{gathered} \text { OPEN } \\ \text { or } \\ \text { GND } \end{gathered}$ | $\begin{gathered} \text { OPEN } \\ \text { or } \\ \text { GND } \end{gathered}$ | - |
| Divide ratio control input high | $\mathrm{V}_{1+2}$ | Connection in the test circuit | Vcc | Vcc | Vcc | - |
| Divide ratio control input low | VIL2 | Connection in the test circuit | $\begin{gathered} \text { OPEN } \\ \text { or } \\ \text { GND } \end{gathered}$ | OPEN <br> or GND | $\begin{gathered} \text { OPEN } \\ \text { or } \\ \text { GND } \end{gathered}$ | - |

## TEST CIRCUIT



## EQUIPMENTS

Signal Generator (HP-8665A)
Counter (HP-5350B) for measuring input sensitivity (Spectrum Analyzer for measuring output frequency)
Oscilloscope for measuring output swing (In measuring output power on Spectrum Analyzer, oscilloscope should be turned off.)

Divide Ratio Setting

|  |  | SW2 |  |
| :---: | :---: | :---: | :---: |
|  |  | $H$ | $L$ |
| SW1 | $H$ | $1 / 2$ | $1 / 4$ |
|  | L | $1 / 4$ | $1 / 8$ |

H: SW pin should be connected to Vccc pin.
L: SW pin should be opened or connected to GND.

## ILLUSTRATION OF THE TEST CIRCUIT ASSEMBLED ON EVALUATION BOARD



Component List

| No. | Value |
| :---: | :---: |
| C1 to C 7 | 1000 pF |
| R1 | $150 \Omega^{\text {Note }}$ |

## Notes for evaluation board

(1) $35 \mu \mathrm{~m}$ thick double sided copper clad $50 \times 50 \times 0.4 \mathrm{~mm}$ polyimide board
(2) Back side : GND pattern
(3) Solder plated on pattern
(4) $\circ \mathrm{O}$ : Through holes
(5) : Remove pattern

Note For Output load of IC, R1 is determined as follows; R1 + Impedance of measurement equipment = $200 \Omega$.

The application circuits and their parameters are for reference only and are not intended for use in actual design-ins.

The usage and applications of $\mu$ PB1509GV should be referred to the application note (Document No. P12611E).

## CHARACTERISTIC CURVES



Divide by 2 mode (Guaranteed operating window: $\mathrm{Vcc}=2.2$ to $5.5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40$ to $+85^{\circ} \mathrm{C}$ )



Divide by 4 mode (Guaranteed operating window: $\mathrm{Vcc}=2.2$ to $5.5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40$ to $+85^{\circ} \mathrm{C}$ )


Divide by 8 mode (Guaranteed operating window: $\mathrm{Vcc}=2.2$ to $5.5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40$ to $+85^{\circ} \mathrm{C}$ )


## $\mathbf{S}_{11}$ vs. Input Frequency



S22 vs. Output Frequency


PACKAGE DIMENSIONS (UNIT: mm)

8 PIN PLASTIC SSOP (175 mil)


## NOTE ON CORRECT USE

(1) Observe precautions for handling because of electro-static sensitive devices.
(2) Form a ground pattern as wide as possible to minimize ground impedance (to prevent undesired operation).
(3) Keep the wiring length of the ground pins as short as possible.
(4) Connect a bypass capacitor (e.g. 1000 pF ) to the Vcc pin.

## RECOMMENDED SOLDERING CONDITIONS

This product should be soldered in the following recommended conditions. Other soldering methods and conditions than the recommended conditions are to be consulted with our sales representatives.
$\mu$ PB1509GV

| Soldering method | $\begin{array}{c}\text { Soldering conditions }\end{array}$ | $\begin{array}{c}\text { Recommended } \\ \text { condition symbol }\end{array}$ |
| :--- | :--- | :---: |
| Infrared ray reflow | $\begin{array}{l}\text { Package peak temperature: } 235^{\circ} \mathrm{C}, \\ \text { Hour: within } 30 \text { s. (more than } 210^{\circ} \mathrm{C} \text { ), } \\ \text { Time: } 3 \text { times, Limited days: } \mathrm{no} .^{*}\end{array}$ | IR35-00-3 |$]$| VP15-00-3 |
| :--- |

* It is the storage days after opening a dry pack, the storage conditions are $25^{\circ} \mathrm{C}$, less than $65 \% \mathrm{RH}$.

Caution The combined use of soldering method is to be avoided (However, except the pin area heating method).

For details of recommended soldering conditions for surface mounting, refer to information document SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL (C10535E).

NEC $\mu$ PB1509GV
[MEMO]


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